Form PTO 1449		U.S. DEPARTMEN	T OF COMMERCE	ATTY DOCKET NO. 283236US2X PCT		SERIAL NO. 10/560,070		
(Modified)		PATENT AND TRA	DEMARK OFFICE					
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LIST OF	REFER	RENCES CITED BY A	PPLICANT	Hiroyuki OCHIAI, et al.				
				FILING DATE		GROUP		
				December 9, 2005		1793		
•				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE		
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			FC	REIGN PATENT DOCUMENTS				
	Ī	DOCUMENT DATE COUNTRY				TRANSLATION		
		NUMBER	DATE	COUNTRY		YES NO		
/G.W./	AO	EP 1 287 936 A1	03/05/2003	Europe				
/G.W./ /G.W./	AP	JP 2000-230996	08/22/2000	Japan (with English abstract)			X	
	AQ	EP 1 092 497 A1	04/18/2001	Europe				
/G.W./	AR	JP 7-75893	03/20/1995	Japan (with English abstract)			X	
	AS							
	AT							
	AU							
	AV							
		OTHER F	REFERENCES	(Including Author, Title, Date, Pertinen	t Pages, e	etc.)		
DATABASE WPI (Week 200359), Thomson Scientific, London , GB, AN 2003-624088 [59], XP002491019, &KR 2003 / G.W./ AW 037459 A, May 14, 2003, abstract, 1 page.								
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	AZ				Add	litional Refe	erences sheet(s) atta	ached
Examiner	/George Wyszomierski/				Date Considered 03/03/2009			
*Examiner: li	nitial if	reference is considered to considered to considered.	d, whether or no	ot citation is in conformance with MPEP 6 n with next communication to applicant.	09; Draw I	ine through	citation if not in	